## 13. TEST SETUP PHOTOGRAPHS

FCC ID: ZNFSP320		HAC (T-COIL) TEST REPORT	🕒 LG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 56 of 58
1M1706280211-09.ZNF	7/5/2017	Portable Handset		Fage 50 01 50
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05/15/2017



Figure 13-1 Test Setup for Wireless Device

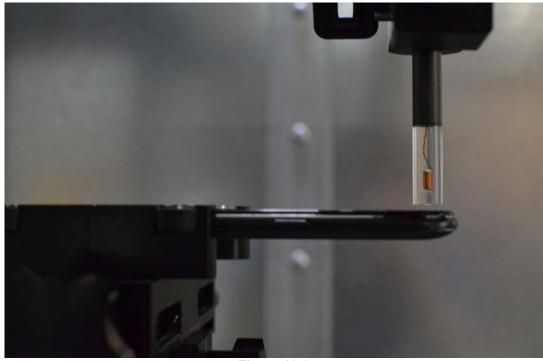


Figure 13-2 Test Setup for Wireless Device

FCC ID: ZNFSP320		HAC (T-COIL) TEST REPORT	🕒 LG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 57 of 58
1M1706280211-09.ZNF	7/5/2017	Portable Handset		Faye 57 01 56
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Figure 13-3 T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

FCC ID: ZNFSP320		HAC (T-COIL) TEST REPORT	🕒 LG	Approved by: Quality Manager
Filename:	Test Dates:	DUT Type:		Page 58 of 58
1M1706280211-09.ZNF	7/5/2017	Portable Handset		Fage 56 01 56
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